

Notice of References Cited		Application/Control No. 10/572,896	Applicant(s)/Patent Under Reexamination SWOBODA, MAREK	
		Examiner DAVID BANH	Art Unit 2854	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,108,197 A	08-2000	Janik, Craig M.	361/683
*	B	US-2002/0016191 A1	02-2002	Ijas et al.	455/575
*	C	US-2002/0051957 A1	05-2002	Schwarzkopf, Dawn Marie	434/227
*	D	US-2002/0080273 A1	06-2002	Harrison et al.	348/552
*	E	US-2002/0084920 A1	07-2002	Olodort et al.	341/22
*	F	US-2002/0118175 A1	08-2002	Liebenow et al.	345/168
*	G	US-2002/0149567 A1	10-2002	Griffin et al.	345/169
*	H	US-2002/0166938 A1	11-2002	Jacobs, Raphael Gamaliel	248/346.01
*	I	US-6,489,576 B2	12-2002	Ito et al.	200/310
*	J	US-2005/0068304 A1	03-2005	Lewis et al.	345/168
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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	X				

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